

<b>Notice of References Cited</b>	Application/Control No. 10/529,669	Applicant(s)/Patent Under Reexamination HEKSTRA ET AL.	
	Examiner Jean W. Désir	Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,147,720 A	11-2000	Guerinot et al.	348/744
*	B	US-6,252,636 B1	06-2001	Bartlett, Terry A.	348/743
*	C	US-6,469,821 B2	10-2002	Bartlett et al.	359/292
*	D	US-6,505,939 B1	01-2003	Bierhuizen et al.	353/94
*	E	US-6,545,814 B2	04-2003	Bartlett et al.	359/636
*	F	US-6,758,579 B2	07-2004	Ishikawa et al.	362/238
*	G	US-6,972,736 B1	12-2005	Wada et al.	345/32
*	H	US-7,053,880 B2	05-2006	Lim et al.	345/102
*	I	US-7,180,554 B2	02-2007	Divelbiss et al.	348/742
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.